

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/737,283	RETSCH ET AL.		
Examiner	Art Unit		

Ana	1	Woodward
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Reexamination				
RETSCH ET AL	•			
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Class	,	Subclass	Da	te	Ex	aminer
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INTERFERENCE SEARCHED					
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525		424/427	10/07	AL	
		436,437			
		438,440	* 1 /		
		441,449			
		452,45	3		
		454,456			
		457,45	91		

(INCLUDING SEARCH STRATEGY)					
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West-all Databases	10/07	N			